This article was downloaded by: [Chongqing University]

On: 15 February 2014, At: 04:49

Publisher: Taylor & Francis

Informa Ltd Registered in England and Wales Registered Number: 1072954 Registered

office: Mortimer House, 37-41 Mortimer Street, London W1T 3JH, UK



## Molecular Crystals and Liquid Crystals

Publication details, including instructions for authors and subscription information:

http://www.tandfonline.com/loi/gmcl20

# Plastic Liquid Crystal Display with Polarizers Integrated Inorganic Conducting and Alignment Layers

Phil Kook Son  $^{\rm a}$  , Suk-Won Choi  $^{\rm a}$  , Sung Soo Kim  $^{\rm b}$  & Seok-Cheol Ko  $^{\rm c}$ 

- <sup>a</sup> Department of Advanced Materials Engineering for Information & Electronics and Regional Innovation Center-Components and Materials for Information Display, Kyung Hee University, Yongin, Republic of Korea
- <sup>b</sup> Department of Chemical Engineering, and Regional Innovation Center-Components and Materials for Information Display, Kyung Hee University, Yongin, Republic of Korea
- <sup>c</sup> Industry-University Cooperation Foundation, Kongju National University, Chungnam, Republic of Korea Published online: 16 Dec 2013.

To cite this article: Phil Kook Son, Suk-Won Choi, Sung Soo Kim & Seok-Cheol Ko (2013) Plastic Liquid Crystal Display with Polarizers Integrated Inorganic Conducting and Alignment Layers, Molecular Crystals and Liquid Crystals, 583:1, 52-59, DOI: <a href="https://doi.org/10.1080/15421406.2013.844221">10.1080/15421406.2013.844221</a>

To link to this article: <a href="http://dx.doi.org/10.1080/15421406.2013.844221">http://dx.doi.org/10.1080/15421406.2013.844221</a>

#### PLEASE SCROLL DOWN FOR ARTICLE

Taylor & Francis makes every effort to ensure the accuracy of all the information (the "Content") contained in the publications on our platform. However, Taylor & Francis, our agents, and our licensors make no representations or warranties whatsoever as to the accuracy, completeness, or suitability for any purpose of the Content. Any opinions and views expressed in this publication are the opinions and views of the authors, and are not the views of or endorsed by Taylor & Francis. The accuracy of the Content should not be relied upon and should be independently verified with primary sources of information. Taylor and Francis shall not be liable for any losses, actions, claims, proceedings, demands, costs, expenses, damages, and other liabilities whatsoever or howsoever caused arising directly or indirectly in connection with, in relation to or arising out of the use of the Content.

This article may be used for research, teaching, and private study purposes. Any substantial or systematic reproduction, redistribution, reselling, loan, sub-licensing, systematic supply, or distribution in any form to anyone is expressly forbidden. Terms &

Conditions of access and use can be found at <a href="http://www.tandfonline.com/page/terms-and-conditions">http://www.tandfonline.com/page/terms-and-conditions</a>

Mol. Cryst. Liq. Cryst., Vol. 583: pp. 52–59, 2013 Copyright © Taylor & Francis Group, LLC

ISSN: 1542-1406 print/1563-5287 online DOI: 10.1080/15421406.2013.844221



## Plastic Liquid Crystal Display with Polarizers Integrated Inorganic Conducting and Alignment Layers

# PHIL KOOK SON,<sup>1</sup> SUK-WON CHOI,<sup>1</sup> SUNG SOO KIM,<sup>2</sup> AND SEOK-CHEOL KO<sup>3,\*</sup>

<sup>1</sup>Department of Advanced Materials Engineering for Information & Electronics and Regional Innovation Center-Components and Materials for Information Display, Kyung Hee University, Yongin, Republic of Korea <sup>2</sup>Department of Chemical Engineering, and Regional Innovation Center-Components and Materials for Information Display, Kyung Hee University, Yongin, Republic of Korea <sup>3</sup>Industry-University Cooperation Foundation, Kongju National University, Chungnam, Republic of Korea

We investigated polarizer integrated conducting and alignment functions  $SiO_2/ITO/SiO_2$  films on polarizer films for the high transmittance and contrast ration of liquid crystal (LC) cell.  $SiO_2/ITO/SiO_2$  films were directly deposited on polarizer films using r. f. magnetron sputtering system at room temperature, which are used as substrates for plastic liquid crystal displays. To align LC molecules, we exposure on  $SiO_2$  film surfaces with low-energy ion beam. Transmittance of twisted nematic (TN) and electrically controlled birefringence (ECB) cell with  $SiO_2/ITO/SiO_2/polarizer$  was higher by  $3\%\sim5\%$  than those of  $SiO_2/ITO/glass/polarizer$  in average visible wavelength.

**Keywords** High transmittance; ion beam; ITO; liquid crystal; polarizer; SiO<sub>2</sub>

#### Introduction

In recent years, the demand for flexible panel display has rapidly increased. Plastic liquid crystal displays (LCDs) have much attention due to their several merits, such as light weight, thinner package, and increased bending capability over the conventional flat LCDs fabricated with rigid glass substrates [1]. However, transmittance of plastic LCDs is generally lower than that of conventional LCDs because plastic substrates have relatively lower transmittance than glass substrates. As one of the essential thermo-plastic polymeric materials, polyethylene terephthalate (PET) has been widely used in various fields since its discovery in the 1940s due to its high tensile and impact strength, adequate CO<sub>2</sub> retention, optical clarity, and design flexibility. Even though these properties of PET have expedited

<sup>\*</sup>Address correspondence to Prof. Seok-Cheol Ko, Industry-University Cooperation Foundation, Kongju National University, Chungnam 314-701, Korea (ROK). Tel.: (+82)41-850-0528; Fax: (+82)41-856-0544. E-mail: suntrac@kongju.ac.kr

its commercial uses in high-value/low-cost applications, its thermal stability is not good and thus, generally it cannot be used with thermal treatment processes with high temperatures to generate a crystalline structure. Due to this, flexible transparent conducting electrodes deposited on plastic film at low temperature during production inevitably have several disadvantages over those deposited on glasses, such as low-transmittance, low-conductivity, and a greater number of defects. Herein, we propose novel plastic LCDs adopting intriguing substrate structure to attain higher transmittance performance.

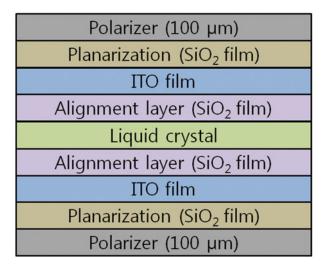
Indium tin oxide (ITO) film has been widely used as a transparent, conducting electrode in liquid crystal displays, light emitting diodes, and solar cell devices. For this kind of film, numerous publications have addressed the challenges of achieving low resistivity and high transmission - an unusual combination of properties in this type of material [2, 3]. Higher transmission requires a material with a band-gap greater than approximately 3.0 eV whilst higher electrical conductivity necessitates a high number of free electron carriers with high mobility. With the creation of oxygen vacancies and by substitutionally doping the  $In^{3+}$  sites in  $In_2O_3$  with  $Sn^{4+}$ , the free carrier density can be increased sufficiently to move the Fermi level into the conduction band whilst the band-gap remains similar to that of the host  $(In_2O_3)$ . Thus, careful control of the deposition parameters during film growth results in coatings that are with both electrically conductive and transparent to visible light.

Various techniques have been developed for liquid crystal (LC) alignment such as the rubbing method, [4] photo alignment, [5] obliquely evaporation of an inorganic film, [6] and ion beam alignment [7, 8]. Rubbed-polyimide (PI) is still being used widely as an LC alignment in mass production of LC displays. The ion beam alignment was introduced recently to overcome the drawbacks of rubbing, such as static charges, creation of debris, and so on. However, there are still unresolved issues associated with the mechanism of LC alignment. Stöhr *et al.* reported on PD of LC effects on an alignment surfaces related to the orientational bonding order in rubbed, ion-beam-treated polyimide, and ion-beam-treated diamond-like-carbon films, by using the near-edge x-ray absorption fine structure measurements analyses.

In this work, we employ polarizers integrated conducting and alignment functions. Figure 1 show a schematic drawing of the polarizers integrated LC cells structure. Proposed substrate structure is SiO<sub>2</sub>/ITO/SiO<sub>2</sub> films on polarizer films. Thus, SiO<sub>2</sub>/ITO/SiO<sub>2</sub> films were directly deposited on conventional polarizer films using r. f. magnetron sputtering system, which are used as substrates for plastic LCDs. We deposited SiO<sub>2</sub> and ITO thin films on polarizers via r. f. magnetron sputtering system at room temperature. Then, low-energy ion beam treatment on outside SiO<sub>2</sub> films was performed to align the LC molecules. Transmittance performances are compared between the twisted nematic (TN) and electrically controlled birefringence (ECB) cell with SiO<sub>2</sub>/ITO/SiO<sub>2</sub>/polarizer and that with SiO<sub>2</sub>/ITO/SiO<sub>2</sub>/glass/polarizer in visible ranges, respectively. In order to evaluate the physical properties of the ITO and SiO<sub>2</sub> film deposited by the proposed technique, we used atomic force microscopy (AFM) and transmittance.

#### **Experimental**

As a shown in Fig. 2, The deposition of the ITO and  $SiO_2$  film on polarizer surfaces, via a r. f. magnetron sputtering system, was performed using method:  $SiO_2$  particles were deposited on a polarizer surfaces by an argon (49.5 sccm) and oxygen gases (0.5 sccm) that were used as the inert gas in the chamber. The base pressure of the chamber was around  $10^{-6}$  torr, while the working process pressure was around  $10^{-2}$  torr. The film with thickness of 20 nm was deposited the range of a room temperature. ITO particles were



**Figure 1.** A schematic drawing of the polarizers integrated LC cells structure. Proposed substrate structure is SiO<sub>2</sub>/ITO/SiO<sub>2</sub> films on polarizer films.

deposited on a polarizer surfaces by argon (49.7 sccm) and oxygen gases (0.3 sccm) that were used as the inert gas in the chamber, respectively. The base pressure of the chamber was around  $10^{-6}$  torr, while the working process pressure was around  $10^{-2}$  torr. The film with a thickness of 20 nm was deposited the range of a room temperature. Therefore, the film with a total thickness of 60 nm (SiO<sub>2</sub>/ITO/SiO<sub>2</sub>) was deposited the range of a room

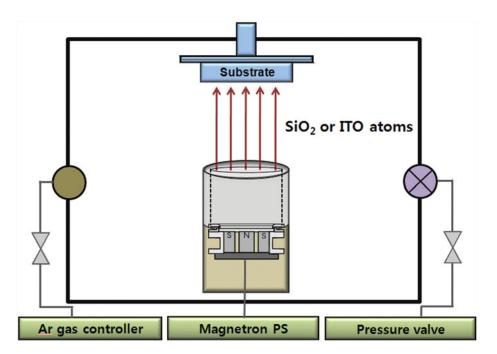


Figure 2. A schematic drawing of r. f. magnetron sputtering system.

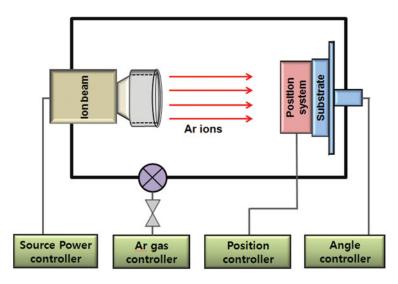


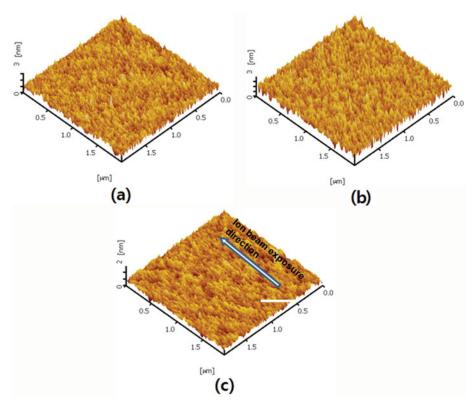
Figure 3. A schematic drawing of ion beam system.

temperature.  $SiO_2/ITO/SiO_2/Polarizer$  surface was bombarded by a low-energy argon ion beam at room temperature. Figure 3 show a schematic drawing of ion beam system. A cold hollow cathode (CHC) type of ion source was used to produce the ion beam. The base pressure of the chamber was around  $10^{-6}$  torr, while the working process pressure was around  $10^{-4}$  torr. The ion beam energy, incident angle, exposure time, and flux density were 120 eV,  $20^{\circ}$ , 10 sec, and  $5 \times 10^{14}$  ions/s·cm<sup>2</sup>, respectively. TN and ECB cell cells with a cell-gap of 4.8 and 4  $\mu$ m were fabricated with a positive LC "Merck MLC-0223," respectively. Also, we compared TN with ECB cell with  $SiO_2/ITO/SiO_2/polarizer$  and that with  $SiO_2/ITO/glass/polarizer$  in visible ranges, respectively.

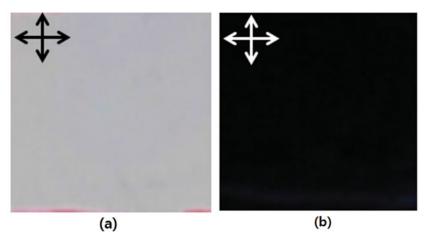
#### Results and Discussion

To obtain more information about the ITO, non-treated SiO<sub>2</sub> and ion beam-treated SiO<sub>2</sub> film on polarizer surfaces, we measured the morphologies properties of the polarizer surfaces. Figure 4 (a)–(c) shows the morphologies of ITO/SiO<sub>2</sub>/polarizer, non-treated SiO<sub>2</sub>/ITO/SiO<sub>2</sub>/polarizer and ion beam-treated SiO<sub>2</sub>/ITO/SiO<sub>2</sub>/polarizer, respectively, measured via AFM. We found that the surface roughness of ITO/SiO<sub>2</sub>/polarizer, non-treated SiO<sub>2</sub>/ITO/SiO<sub>2</sub>/polarizer and ion beam-treated SiO<sub>2</sub>/ITO/SiO<sub>2</sub>/polarizer was 1.315, 1.182 and 2.021 nm, respectively. Therefore, we found that ion beam-treated SiO<sub>2</sub>/ITO/SiO<sub>2</sub>/polarizer films were increased than non-treated SiO<sub>2</sub> films/ITO/SiO<sub>2</sub>/polarizer.

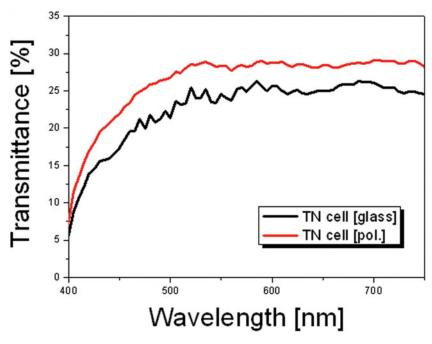
Figure 5 shows images of TN cells between crossed polarizers without and with the electric field. However, upon applying an electric field to a cell, non-uniform alignment and disclination lines can be observed. On the other hand, with the ion beam exposure, we can achieve uniformity in switching behavior upon applying an electric field. Figure 6 shows the transmittance performances are compared between the TN cell with SiO<sub>2</sub>/ITO/SiO<sub>2</sub>/polarizer and that with SiO<sub>2</sub>/ITO/glass/polarizer in visible ranges. We found that TN cell of SiO<sub>2</sub>/ITO/SiO<sub>2</sub>/polarizer were higher about 5% than that of SiO<sub>2</sub>/ITO/glass/polarizer at average visible wavelength. The measured contrast ratio of a



**Figure 4.** (a)  $\sim$  (c) shows the morphologies of ITO SiO<sub>2</sub>/polarizer, non-treated SiO<sub>2</sub>/ITO/SiO<sub>2</sub>/polarizer and ion beam-treated SiO<sub>2</sub>/ITO/SiO<sub>2</sub>/polarizer film surfaces, respectively, measured via AFM.



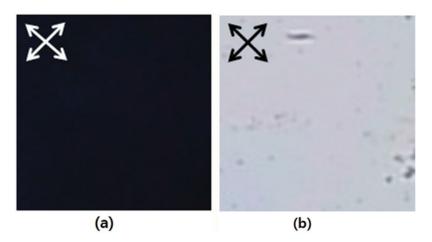
**Figure 5.** The images of TN cells between crossed polarizers (a) without and (b) with the electric field.



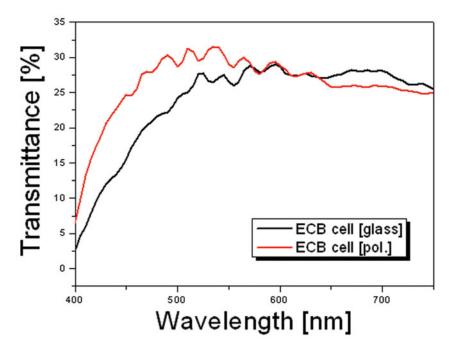
**Figure 6.** Transmittance are compared between the TN cell with SiO<sub>2</sub>/ITO/SiO<sub>2</sub>/polarizer and that with SiO<sub>2</sub>/ITO/glass/polarizer in visible ranges.

TN cell with SiO<sub>2</sub>/ITO/SiO<sub>2</sub>/polarizer and that with SiO<sub>2</sub>/ITO/glass/polarizer in the normal direction was about 323 and 298 at 550 nm, respectively.

Figure 7 shows images of ECB cells between crossed polarizers without and with the electric field. With the ion beam exposure, we can achieve uniformity in switching behavior upon applying an electric field. Figure 8 shows the transmittance performances are compared between the ECB cell with SiO<sub>2</sub>/ITO/SiO<sub>2</sub>/polarizer and



**Figure 7.** The images of ECB cells between crossed polarizers (a) without and (b) with the electric field.



**Figure 8.** Transmittance are compared between the ECB cell with SiO<sub>2</sub>/ITO/SiO<sub>2</sub>/polarizer and that with SiO<sub>2</sub>/ITO/glass/polarizer in visible ranges.

that with SiO<sub>2</sub>/ITO/glass/polarizer in visible ranges at average visible wavelength. We found that ECB cell of SiO<sub>2</sub>/ITO/SiO<sub>2</sub>/polarizer were higher about 3% than that of SiO<sub>2</sub>/ITO/glass/polarizer. Therefore, we suggest that polarizers integrated conducting and alignment functions SiO<sub>2</sub>/ITO/SiO<sub>2</sub>/polarizer have high transmittance than conventional LC cells of SiO<sub>2</sub>/ITO/glass/polarizer. The measured contrast ratio of an ECB cell with SiO<sub>2</sub>/ITO/SiO<sub>2</sub>/polarizer and that with SiO<sub>2</sub>/ITO/glass/polarizer in the normal direction was about 338 and 319 at 550 nm, respectively.

#### Conclusions

We manufactured polarizers integrated conducting and alignment functions SiO<sub>2</sub>/ITO/SiO<sub>2</sub>/polarizer films. We deposited SiO<sub>2</sub> and ITO thin films on polarizers via r. f. magnetron sputtering system at room temperature. Then, low-energy ion beam treatment on outside SiO<sub>2</sub> films was performed to align the LC molecules. Transmittance of TN and ECB cell with SiO<sub>2</sub>/ITO/SiO<sub>2</sub>/polarizer was higher about 3~5% than those of conventional SiO<sub>2</sub>/ITO/glass/polarizer in average visible ranges. Using our structure, higher transmittance-plastic LCDs can be fabricated.

### Acknowledgment

This work was supported by a grant from Kyung Hee University in 2012 (KHU-20120184).

## References

- [1] Granqvist, C. G. (2007). Sol. Energy Mater. Sol. Cells, 91, 1529.
- [2] Tahar, R. B. H., Ban, T., Ohya, Y., & Takahashi, Y. (1998). J. Appl. Phys., 83, 2631.
- [3] Wong, F. L., Fung, M. K., Tong, S. W., Lee, C. S., & Lee, S. T. (2004). Thin Solid Films, 466, 225.
- [4] Mauguin, Bull (1911). Soc. Fr. Min., 34, 71.
- [5] Jain, S. C., & Kitzerow, H.-S. (1994). Appl. Phys. Lett., 64, 2946.
- [6] Janning, J. L. (1972). Appl. Phys. Lett., 21, 173.
- [7] Son, P. K., Park, J. H., Cha, S. S., Kim, J. C., Yoon, T.-H., Rho, S. J., Jeon, B. K., Kim, J. S., Lim, S. K., & Kim, K. H. (2006). Appl. Phys. Lett., 88, 263512..
- [8] Son, P. K., Park, J. H., Kim, J. C., Yoon, T.-H., Rho, S. J., Jeon, B. K., Shin, S. T., Kim, J. S., & Lim, S. K. (2007). Appl. Phys. Lett., 91, 103513.